

BUK9M31-60EL

Single N-channel 60 V, 21 mOhm logic level MOSFET in LFPAK33 using Enhanced SOA technology

pril 2022

Product data sheet

1. General description

Single, logic level, N-channel MOSFET in LFPAK33 using Application specific (ASFET) Enhanced SOA technology. This product has been designed and qualified to AEC-Q101 for use in linear mode in airbag applications.

2. Features and benefits

- Fully automotive qualified to AEC-Q101 at 175 °C
- Enhanced SOA technology for improved linear mode performance
- LFPAK copper clip package technology:
 - · High robustness and current handling capability
 - · Gull wing leads for easy AOI inspection and exceptional board level reliability

3. Applications

- · 12 V automotive systems
- Airbag squib voltage regulator MOSFET

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	60	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	-	35	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	70.2	W
Static characte	Static characteristics						
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_{D} = 10 A; T_{j} = 25 °C; Fig. 13		11.6	16.5	20.6	mΩ
Dynamic characteristics							
Q_{GD}	gate-drain charge	I _D = 10 A; V _{DS} = 48 V; V _{GS} = 5 V; T _j = 25 °C; <u>Fig. 15</u> ; <u>Fig. 16</u>		-	6	11.9	nC

^{[1] 35} A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.



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5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source		D
3	S	source		
4	G	gate		G_(□□□□□)
mb	D	Mounting base; connected to drain	1 2 3 4 LFPAK33 (SOT1210)	mbb076 S

6. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK9M31-60EL	LFPAK33	Plastic, single ended surface mounted package (LFPAK33); 8 leads; 0.65 mm pitch	SOT1210

7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9M31-60EL	9316EL

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). T_i = 25 °C unless otherwise stated.

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	60	V
V _{GS}	gate-source voltage	T _j = 175 °C		-10	10	V
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	70.2	W
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	35	Α
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>		-	27	А
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$; $Fig. 3$; $Fig. 4$		-	155	А
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T _{sld(M)}	peak soldering temperature			-	260	°C
Source-drai	n diode		'			
I _S	source current	T _{mb} = 25 °C		-	35	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$		-	155	А

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Symbol	Parameter	Conditions		Min	Max	Unit
Avalanche rugg	Avalanche ruggedness					
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	I_D = 28.7 A; $V_{sup} \le 60$ V; R_{GS} = 50 Ω; V_{GS} = 5 V; $T_{j(init)}$ = 25 °C; unclamped; t_p = 36 μs; Fig. 5	[2] [3]	-	40.4	mJ
I _{AS}	non-repetitive avalanche current	$V_{sup} = 60 \text{ V}; V_{GS} = 5 \text{ V}; T_{j(init)} = 25 \text{ °C};$ $R_{GS} = 50 \Omega; Fig. 5$	[2] [3]	-	28.7	А

- [1] 35 A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.
- [2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [3] Refer to application note AN10273 for further information.

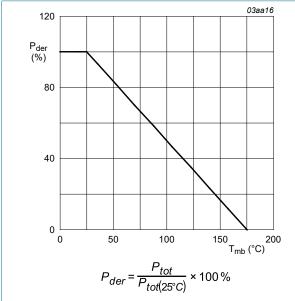
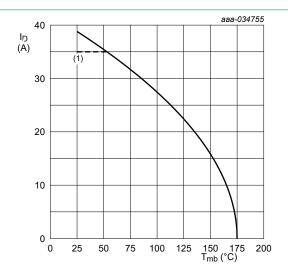
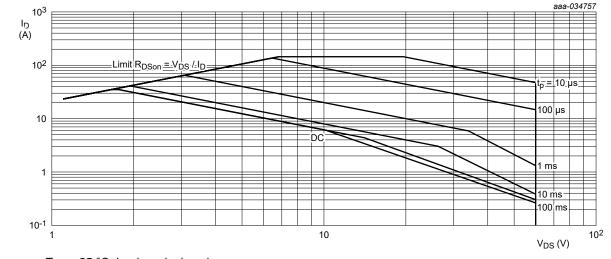


Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$ (1) 35 A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

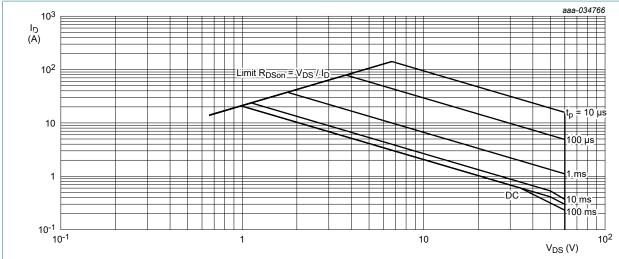
Fig. 2. Continuous drain current as a function of mounting base temperature



 T_{mb} = 25 °C; I_{DM} is a single pulse

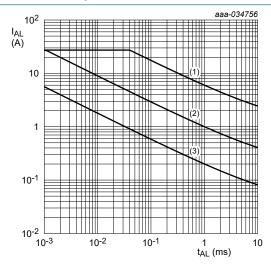
Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

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T_{mb} = 125 °C; I_{DM} is a single pulse

Fig. 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage



(1) $T_{j \text{ (init)}}$ = 25 °C; (2) $T_{j \text{ (init)}}$ = 150 °C; (3) Repetitive Avalanche

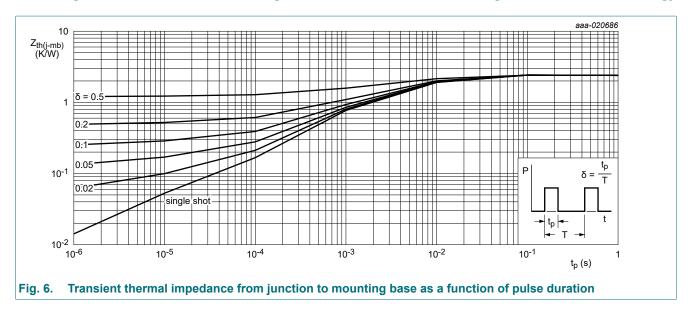
Fig. 5. Avalanche rating; avalanche current as a function of avalanche time

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. 6	-	1.91	2.14	K/W

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10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static charac	cteristics					,
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	60	66	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -40 °C	54	62	-	V
		I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	54	61	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; <u>Fig. 11</u> ; <u>Fig. 12</u>	1.35	1.82	2.05	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ Fig. 12	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; Fig. 12$	-	-	2.45	V
$\Delta V_{GS(th)}/\Delta T$	gate-source threshold voltage variation with temperature	25 °C ≤ T _j ≤ 175 °C	-	-4.3	-	mV/K
I _{DSS}	drain leakage current	V _{DS} = 60 V; V _{GS} = 0 V; T _j = 25 °C	-	0.005	1	μA
		V _{DS} = 16 V; V _{GS} = 0 V; T _j = 125 °C	-	0.68	10	μA
		V _{DS} = 60 V; V _{GS} = 0 V; T _j = 175 °C	-	20.7	500	μA
I _{GSS}	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
		V _{GS} = -16 V; V _{DS} = 0 V; T _i = 25 °C	-	2	100	nA

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 ^{\circ}\text{C};$ Fig. 13	11.6	16.5	20.6	mΩ
		V_{GS} = 10 V; I_D = 10 A; T_j = 105 °C; Fig. 14	17.8	25.5	33.1	mΩ
		V_{GS} = 10 V; I_D = 10 A; T_j = 125 °C; Fig. 14	19.7	28.1	36.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 175 °C;$ Fig. 14	24.7	35.2	45.8	mΩ
		V_{GS} = 4.5 V; I_D = 10 A; T_j = 25 °C; Fig. 13	17.3	24.7	30.9	mΩ
		V_{GS} = 4.5 V; I_D = 10 A; T_j = 105 °C; Fig. 14	26.3	37.6	48.8	mΩ
		V_{GS} = 4.5 V; I_D = 10 A; T_j = 125 °C; Fig. 14	28.9	41.2	53.6	mΩ
		V_{GS} = 4.5 V; I_D = 10 A; T_j = 175 °C; Fig. 14	35.7	51	66.3	mΩ
R_G	gate resistance	f = 1 MHz; T _i = 25 °C	-	1.85	-	Ω
Dynamic ch	naracteristics					
Q _{G(tot)}	total gate charge	I _D = 10 A; V _{DS} = 48 V; V _{GS} = 4.5 V; T _j = 25 °C; <u>Fig. 15</u> ; <u>Fig. 16</u>	-	12.8	18	nC
		I _D = 10 A; V _{DS} = 48 V; V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 15</u> ; <u>Fig. 16</u>	-	26.1	36.6	nC
Q_{GS}	gate-source charge	I _D = 10 A; V _{DS} = 48 V; V _{GS} = 5 V;	-	3.7	5.5	nC
Q_{GD}	gate-drain charge	T _j = 25 °C; <u>Fig. 15</u> ; <u>Fig. 16</u>	-	6	11.9	nC
C _{iss}	input capacitance	V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz;	-	1334	1774	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 17</u>	-	135	162	pF
C _{rss}	reverse transfer capacitance	-	-	79	108	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 48 \text{ V}; R_L = 5 \Omega; V_{GS} = 5 \text{ V};$	-	8.3	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 ^{\circ}C$	-	17.7	-	ns
t _{d(off)}	turn-off delay time	1	-	16.5	-	ns
t _f	fall time	1	-	12.9	-	ns
9 _{fs}	transfer conductance	V _{DS} = 8 V; I _D = 10 A	-	24	-	S
Source-dra	in diode	1	1			1
V_{SD}	source-drain voltage	I _S = 10 A; V _{GS} = 0 V; T _i = 25 °C; <u>Fig. 18</u>	-	0.83	1	V
t _{rr}	reverse recovery time	$I_S = 10 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	26.3	-	ns
Q _r	recovered charge	V _{DS} = 30 V; T _j = 25 °C; <u>Fig. 19</u>	[1] -	28.5	-	nC

^[1] includes capacitive recovery

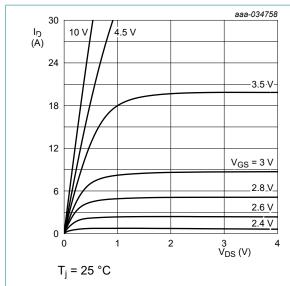


Fig. 7. Output characteristics; drain current as a function of drain-source voltage; typical values

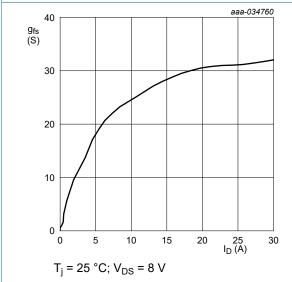


Fig. 9. Forward transconductance as a function of drain current; typical values

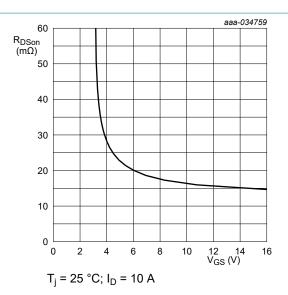


Fig. 8. Drain-source on-state resistance as a function of gate-source voltage; typical values

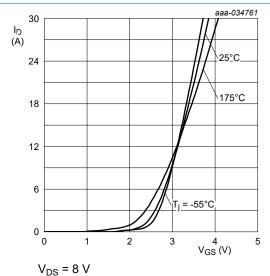


Fig. 10. Transfer characteristics; drain current as a function of gate-source voltage; typical values

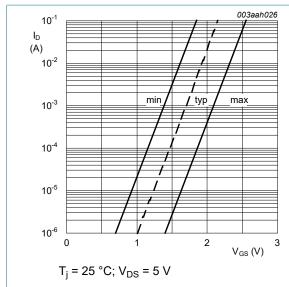


Fig. 11. Sub-threshold drain current as a function of gate-source voltage

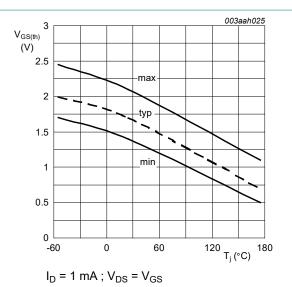


Fig. 12. Gate-source threshold voltage as a function of junction temperature

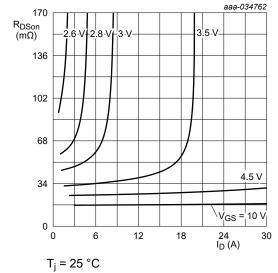


Fig. 13. Drain-source on-state resistance as a function of drain current; typical values

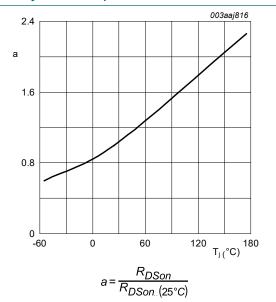


Fig. 14. Normalized drain-source on-state resistance factor as a function of junction temperature

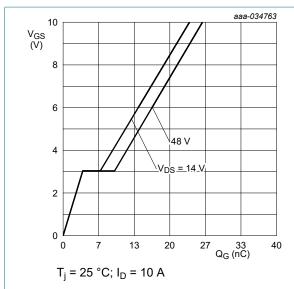


Fig. 15. Gate-source voltage as a function of gate charge; typical values

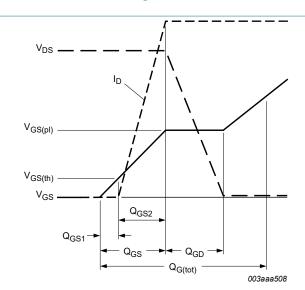


Fig. 16. Gate charge waveform definitions

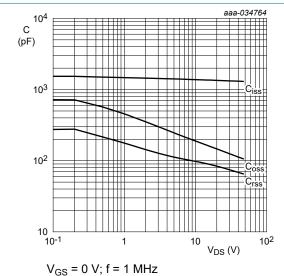
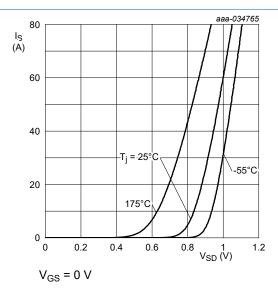


Fig. 17. Input, output and reverse transfer capacitances | Fig. 18. Source-drain (diode forward) current as a as a function of drain-source voltage; typical values



function of source-drain (diode forward) voltage; typical values

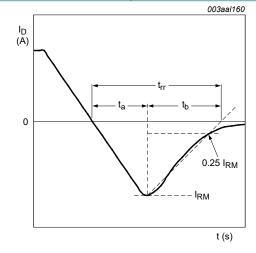
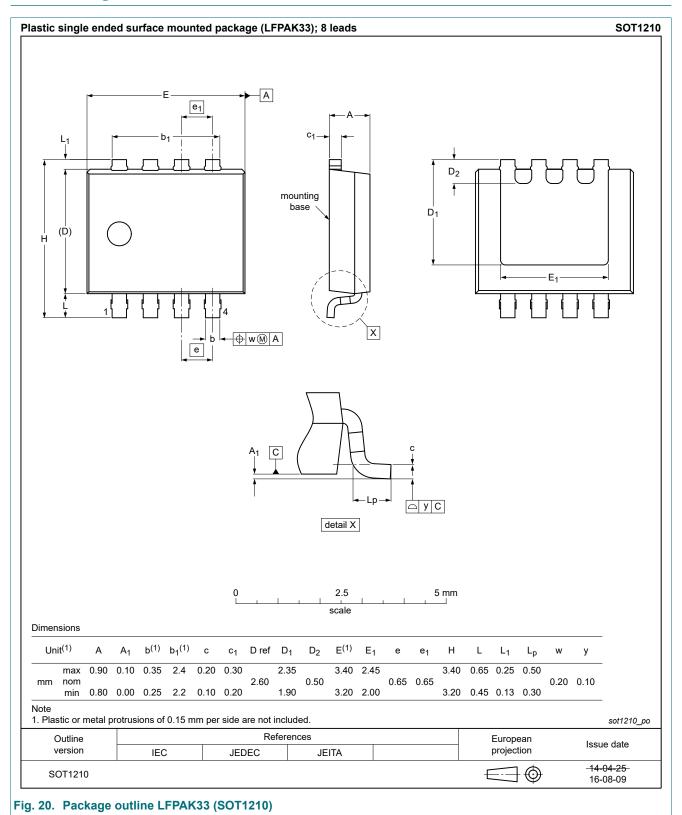


Fig. 19. Reverse recovery timing definition

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11. Package outline



Single N-channel 60 V, 21 mOhm logic level MOSFET in LFPAK33 using Enhanced SOA technology

12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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